

# AOK030V75X2Q

750V αSiC Silicon Carbide Power MOSFET

#### **Features**

- Proprietary αSiC MOSFET technology
- · Low loss, with low RDS, ON
- · Fast switching with low R<sub>G</sub> and low capacitance
- Optimized gate drive voltage (V<sub>GS</sub> = 15V)
- Low reverse recovery diode (Qrr)
- AEC-Q101 Automotive Qualified

# **Applications**

- · xEV Charger
- Electric Vehicle Supply Equipment (EVSE)
- Motor Drives
- · Automotive Inverters

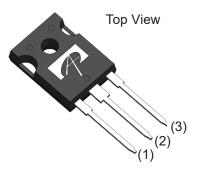
## **Product Summary**

V <sub>DS</sub> @ T <sub>J, max</sub>	750V
$I_{DM}$	100A
R <sub>DS(ON), typ</sub>	$30 m\Omega$
Q <sub>rr</sub>	116nC
E <sub>OSS</sub> @ 400V	18µJ
100 % UIS Tested	

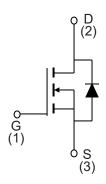




# **Pin Configuration**







Ordering Part Number	Package Type	kage Type Form Shipping Quantity	
AOK030V75X2Q	TO-247-3L	Tube	30/Tube

# **Absolute Maximum Ratings**

(T<sub>A</sub> = 25°C, unless otherwise noted)

Symbol		AOK030V75X2Q	Units	
V <sub>DS</sub>	Drain-Source Voltage	750	V	
V <sub>GS, MAX</sub>		Maximum	-8/+18	
V <sub>GS,OP,TRANS</sub>	Gate-Source Voltage	Max Transient <sup>(A)</sup>	-8/+20	V
V <sub>GS,OP</sub>		Recommended Operating <sup>(B)</sup>	-5/+15	
I <sub>D</sub>	Continuous Drain Current	T <sub>C</sub> =25°C	55	А
		T <sub>C</sub> = 100°C	39	
I <sub>DM</sub>	Pulsed Drain Current <sup>(C)</sup>	100		
E <sub>AS</sub>	Single Pulsed Avalanche Ene	0.5	J	
P <sub>D</sub>	Power Dissipation <sup>(C)</sup>		192	W
T <sub>J,</sub> T <sub>STG</sub>	Junction and Storage Temperature Range		-55 to 175	°C
T <sub>L</sub>	Maximum lead temperature f	300	°C	



#### **Thermal Characteristics**

Symbol	Parameter		Max	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient <sup>(E,F)</sup>		40	°C/W
$R_{\theta JC}$	Maximum Junction-to-Case <sup>(G)</sup>	0.65	0.78	°C/W

#### **Electrical Characteristics**

 $(T_{\Delta} = 25^{\circ}C. \text{ unless otherwise noted})$ 

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC							
D\/	Drain-Source Breakdown Voltage	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C I <sub>D</sub> =250μA, V <sub>GS</sub> =0V, T <sub>J</sub> =150°C		750			V
BV <sub>DSS</sub>	Diain-Source Breakdown Voltage			750			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =750V, V <sub>GS</sub> =0V				100	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> =+15/-5	ίV			250	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =12mA		1.8	2.5	3.5	V
	Static Drain-Source On-Resistance	T <sub>J</sub> =25°C	T <sub>J</sub> =25°C		30	42	mΩ
R <sub>DS(ON)</sub>		V <sub>GS</sub> =15V, I <sub>D</sub> =12A	T <sub>J</sub> =175°C		45		11122
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =20V, I <sub>D</sub> =12V			9.3		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =12A,V <sub>GS</sub> =-5V			4	5	V
DYNAMIC							
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =400V, f=100kHz			2306		pF
C <sub>oss</sub>	Output Capacitance				190		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				13		pF
E <sub>oss</sub>	Coss Stored Energy				18		μJ
$R_G$	Gate Resistance				1.5		Ω
SWITCHIN	G						
$Q_{g}$	Total Gate Charge				81		nC
$Q_{gs}$	Gate Source Charge	$V_{GS} = -5/+15V$ , $V_{DS} = 520V$ , $I_D = 12A$			27		nC
$Q_{gd}$	Gate Drain Charge				20		nC
t <sub>D(on)</sub>	Turn-On Delay Time				12		ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =-5V/+15V, $V_{DS}$ =400V, $I_{D}$ =40A, $R_{G,ON}$ =2 $\Omega$ , $R_{G,OFF}$ =0 $\Omega$ L=60 $\mu$ H FWD: AOK030V75X2 $\Omega$			33		ns
t <sub>D(off)</sub>	Turn-Off Delay Time				16		ns
t <sub>f</sub>	Turn-Off Fall Time				4		ns
E <sub>on</sub>	Turn-On Energy				389		μJ
E <sub>off</sub>	Turn-Off Energy				11		μJ
E <sub>tot</sub>	Total Switching Energy				400		μJ
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =40A,dI/dt=2500A/μs, V <sub>DS</sub> =400V			32		ns
I <sub>rm</sub>	Peak Reverse Recovery Current				8		А
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge				116		nC

D. L=5mH,  $I_{AS}$ =13.5A,  $R_{G}$ =10 $\Omega$ , Starting  $T_{J}$ =25°C

with  $T_A = 25$ °C.

F. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$ and case to ambient.

 $_{\mbox{\scriptsize G.}}$  The value of  $R_{\mbox{\tiny BJC}}$  is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=175°C.

H. The static characteristics in Figures 1 to 8 are obtained using < 300 µs pulses, duty cycle 0.5% max.

I. These curves are based on Reuc which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)} = 175^{\circ}C$ . The SOA curve provides a single pulse rating.

A. t<sub>ON</sub><1% \*(Duty Cycle)/(Frequency), t<25 hrs over lifetime B. Device can be operated at V<sub>GS</sub>=0/15V. Actual operating V<sub>GS</sub> will depend on application specifics such as parasitic inductance and dV/dt but should not exceed maximum ratings. C. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =175°C, using junction-to-

case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

E. The value of R<sub>BJA</sub> is measured with the device in a still air environment



# **Typical Electrical and Thermal Characteristics**

T<sub>A</sub> = 25°C, unless otherwise specified.

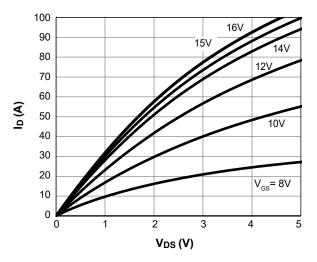


Figure 1. On-region Characteristics T<sub>J</sub> = 25°C

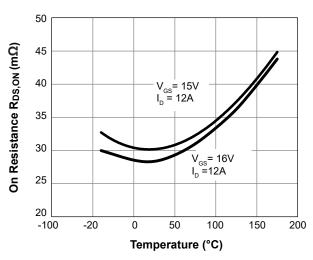


Figure 3. On-resistance vs. Junction Temperature

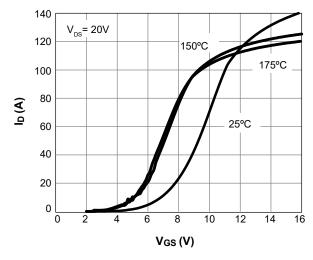


Figure 5. Transfer Characteristics

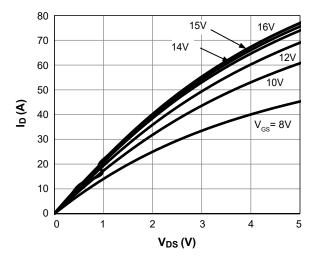


Figure 2. On-region Characteristics T<sub>J</sub> = 175°C

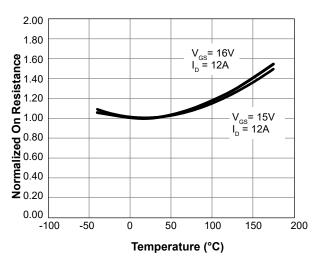


Figure 4. Normalized On-resistance vs. Junction Temperature

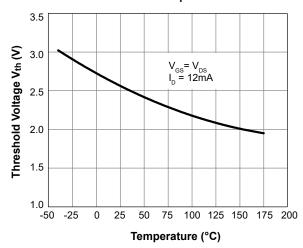


Figure 6. Threshold Voltage vs. Junction Temperature

Rev. 1.1 July 2025 **www.aosmd.com** Page 3 of 8



# **Typical Electrical and Thermal Characteristics**

T<sub>A</sub> = 25°C, unless otherwise specified.

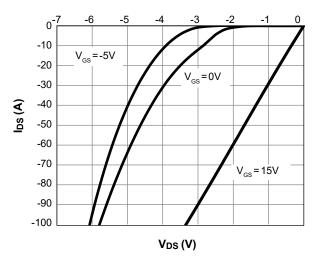


Figure 7. Body-diode Characteristics T<sub>J</sub> = 25°C

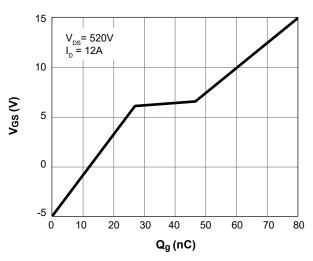


Figure 9. Gate-charge Characteristics

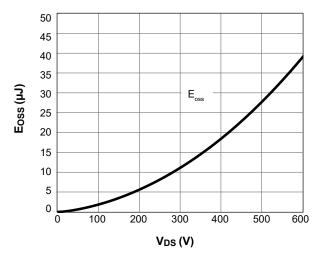


Figure 11. Coss Stored Energy

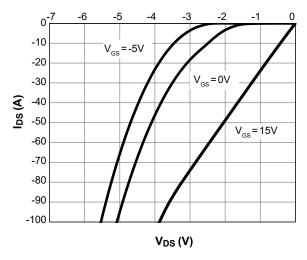


Figure 8. Body-diode Characteristics T<sub>J</sub> = 175°C

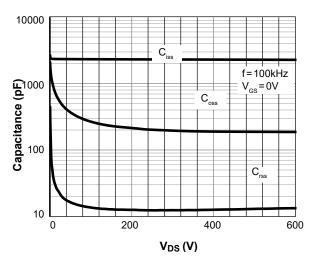


Figure 10. Capacitance Characteristics

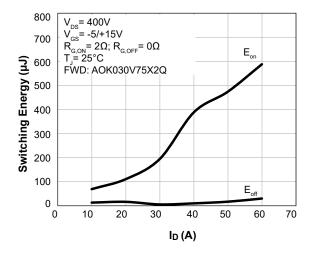


Figure 12. Switching Energy vs. Drain Current

Rev. 1.1 July 2025 **www.aosmd.com** Page 4 of 8



# Typical Electrical and Thermal Characteristics (Continued)

T<sub>A</sub> = 25°C, unless otherwise specified.

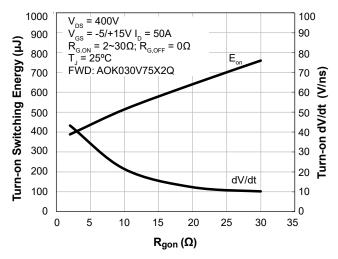


Figure 13. Turn-On Energy and dV/dt vs. External Gate Resistance

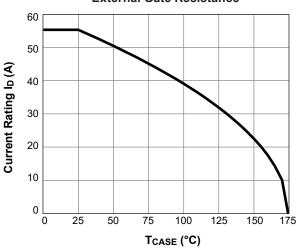


Figure 15. Current De-rating (Note I)

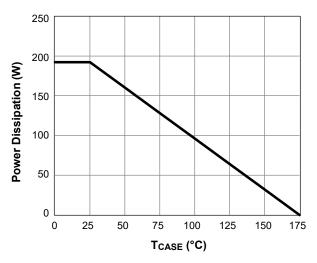


Figure 14. Power De-rating (Note I)

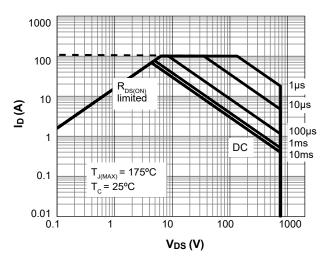


Figure 16. Maximum Forward Biased Safe Operating Area for AOK030V75X2Q (Note I)

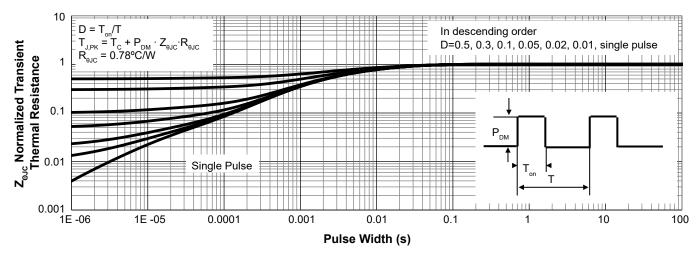


Figure 17. Normalized Maximum Transient Thermal Impedance for AOK030V75X2Q (Note I)

Rev. 1.1 July 2025 **www.aosmd.com** Page 5 of 8



# **Test Circuits and Waveforms**

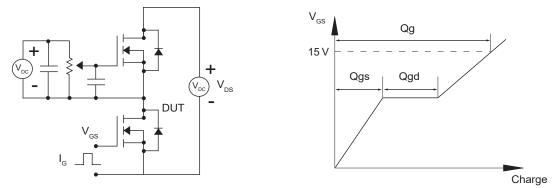


Figure 18. Gate Charge Test Circuits and Waveforms

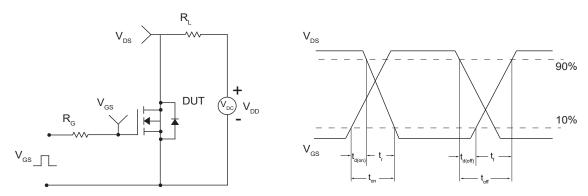


Figure 19. Resistive Switching Test Circuit and Waveforms

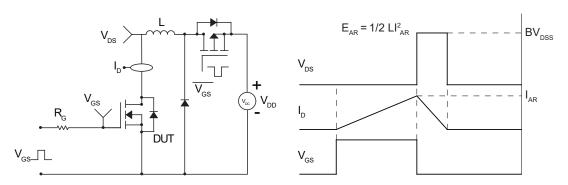


Figure 20. Unclamped Inductive Switching (UIS) Test Circuit and Waveforms

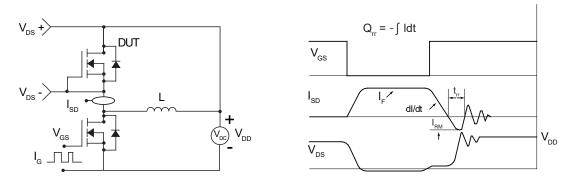
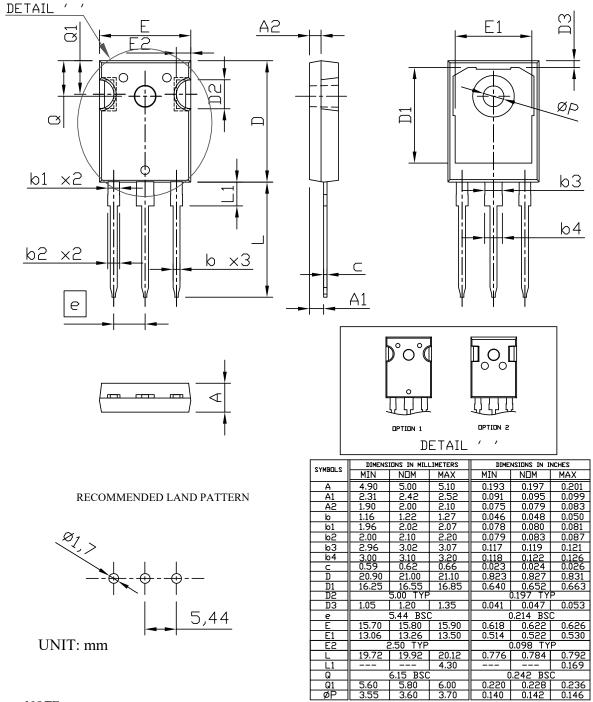


Figure 21. Diode Recovery Test Circuits and Waveforms

Rev. 1.1 July 2025 **www.aosmd.com** Page 6 of 8



# Package Dimensions, TO-247-3L



#### **NOTE**

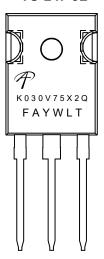
- 1. PAKCAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.

Rev. 1.1 July 2025 **www.aosmd.com** Page 7 of 8



## Part Marking

## AOK030V75X2Q TO-247-3L



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Rev. 1.1 July 2025 www.aosmd.com Page 8 of 8